

# Search Notes



Application/Control No.

10/035,504

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

JACKSON ET AL.

Art Unit

3767

## SEARCHED

Class	Subclass	Date	Examiner
604	22 27	12/9/2005	<i>meh.</i>
	30 35		
	39 43		
	93.01		
	118 131		
	151 173		
	264 266		
	267 268		
606	79 80		
	81 84		
	85 109		
	159 169		
	170 171		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
as	above	12/10/2005	<i>meh.</i>
Interference search, see history printout		12/10/2005	<i>meh.</i>

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	3/26/2005	<i>meh.</i>
Inventor name search	3/26/2005	<i>meh.</i>